## Notice of References Cited Application/Control No. 10/582,852 Examiner OMONIYI A. OBAYANJU Applicant(s)/Patent Under Reexamination ONISHI ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	Α	US-2001/0019960	09-2001	Takayama et al.	455/456	
*	В	US-2004/0059498	03-2004	Chinomi et al.	701/200	
	С	US-				
	D	US-				
	Е	US-				
	F	US-				
	G	US-				
	Н	US-		1 = 1		
	ı	US-	1			
	J	US-				
	К	US-				
	L	US-				
	М	US-				

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	_			2-12-3-6	ı C.	

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.